FETKYTM

Power MOSFET and Schottky Diode Dual SO-8 Package

Features

- High Efficiency Components in a Single SO-8 Package
- High Density Power MOSFET with Low R_{DS(on)}, Schottky Diode with Low V_F
- Logic Level Gate Drive
- Independent Pin–Outs for MOSFET and Schottky Die Allowing for Flexibility in Application Use
- Less Component Placement for Board Space Savings
- SO-8 Surface Mount Package, Mounting Information for SO-8 Package Provided
- Pb-Free Package is Available

Applications

Power Management in Portable and Battery—Powered Products, i.e.:
 Computers, Printers, PCMCIA Cards, Cellular and Cordless Telephones

MOSFET MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	-20	V
Gate-to-Source Voltage - Continuous	V _{GS}	±10	V
Thermal Resistance, Junction-to-Ambient (Note 1) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 4)	R _{θJA} P _D I _D I _{DM}	175 0.71 -2.3 -1.45 -9.0	°C/W A A A
Thermal Resistance, Junction-to-Ambient (Note 2) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 4)	R _{θJA} P _D I _D I _{DM}	105 1.19 -2.97 -1.88 -12	°C/W A A A
Thermal Resistance, Junction-to-Ambient (Note 3) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ T _A = 25°C Continuous Drain Current @ T _A = 100°C Pulsed Drain Current (Note 4)	R _{θJA} P _D I _D I _D	62.5 2.0 -3.85 -2.43 -15	°C/W W A A
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = -20$ Vdc, $V_{GS} = -4.5$ Vdc, Peak $I_L = -5.0$ Apk, $L = 28$ mH, $R_G = 25$ Ω)	E _{AS}	350	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Minimum FR-4 or G-10 PCB, Steady State.
- Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), Steady State.
- Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.
- 4. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.



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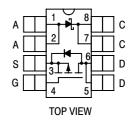
http://onsemi.com

 $\begin{array}{c} \text{MOSFET} \\ \text{-2.3 AMPERES, -20 VOLTS} \\ \text{90 m}\Omega \text{ @ V}_{\text{GS}} = \text{-4.5 V} \end{array}$

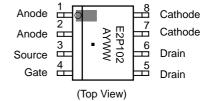
SCHOTTKY DIODE 2.0 AMPERES, 20 VOLTS 580 mV @ I_F = 2.0 A



SO-8 CASE 751 STYLE 18



MARKING DIAGRAM & PIN ASSIGNMENTS



E2P102 = Device Code A = Assembly Location

Y = Year WW = Work Week ■ Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMSD2P102LR2	SO-8	2500/Tape & Reel
NTMSD2P102LR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

SCHOTTKY MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage DC Blocking Voltage	$V_{RRM} \ V_{R}$	20	V
Average Forward Current (Note 5) (Rated V _R , T _A = 100°C)	lo	1.0	Α
Peak Repetitive Forward Current (Note 5) (Rated V _R , Square Wave, 20 kHz, T _A = 105°C)	I _{FRM}	2.0	А
Non-Repetitive Peak Surge Current (Note 5) (Surge Applied at Rated Load Conditions, Half-Wave, Single Phase, 60 Hz)	I _{FSM}	20	Α

FI FCTRICAL CHARACTERISTICS (Tu = 25°C unless otherwise noted) (Note 6)

Cha	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
$\begin{array}{l} \text{Drain-to-Source Breakdown Voltage} \\ \text{(V}_{GS} = 0 \text{ Vdc, I}_{D} = -250 \mu\text{Adc)} \\ \text{Temperature Coefficient (Positive)} \end{array}$		V _{(BR)DSS}	-20 -	_ -12.7		Vdc mV/°C
Zero Gate Voltage Drain Current ($V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = (V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 0 \text{ Vdc}$		I _{DSS}	- -	- -	-1.0 -25	μAdc
Zero Gate Voltage Drain Current (V _{GS} = 0 Vdc, V _{DS} = -20 Vdc, T _J =	= 25°C)	I _{DSS}	-	_	-2.0	μAdc
Gate-Body Leakage Current (V _{GS} = -10 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	-	_	-100	nAdc
Gate-Body Leakage Current (V _{GS} = +10 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	ı	-	100	nAdc
ON CHARACTERISTICS						
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_{D} = -250 \mu Adc)$ Temperature Coefficient (Negative))	V _{GS(th)}	-0.5 -	-0.90 2.5	-1.5 -	Vdc mV/°C
Static Drain-to-Source On-State Res $ \begin{array}{l} (\text{V}_{GS} = -4.5 \text{ Vdc, I}_{D} = -2.4 \text{ Adc}) \\ (\text{V}_{GS} = -2.7 \text{ Vdc, I}_{D} = -1.2 \text{ Adc}) \\ (\text{V}_{GS} = -2.5 \text{ Vdc, I}_{D} = -1.2 \text{ Adc}) \end{array} $	istance	R _{DS(on)}	- - -	0.070 0.100 0.110	0.090 0.130 0.150	Ω
Forward Transconductance $(V_{DS} = -10 \text{ Vdc}, I_D = -1.2 \text{ Adc})$		9FS	-	4.2	-	Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	_	550	750	pF
Output Capacitance	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C _{oss}	-	200	300	
Reverse Transfer Capacitance		Cree	_	100	175	1

^{5.} Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.
6. Handling precautions to protect against electrostatic discharge is mandatory.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued) (Note 7)

Characteristic			Min	Тур	Max	Unit	
SWITCHING CHARACTERISTICS (Notes 8 & 9)							
Turn-On Delay Time		t _{d(on)}	_	10	20	ns	
Rise Time	$(V_{DD} = -10 \text{ Vdc}, I_D = -2.4 \text{ Adc},$	t _r	-	35	65		
Turn-Off Delay Time	$V_{GS} = -4.5 \text{ Vdc}, R_G = 6.0 \Omega)$	t _{d(off)}	-	33	60		
Fall Time		t _f	-	29	55		
Turn-On Delay Time		t _{d(on)}	-	15	-	ns	
Rise Time	(V _{DD} = −10 Vdc, I _D = −1.2 Adc,	t _r	-	40	-	1	
Turn-Off Delay Time	$V_{GS} = -2.7 \text{ Vdc}, R_G = 6.0 \Omega)$	t _{d(off)}	-	35	-	1	
Fall Time		t _f	-	35	-		
Total Gate Charge		Q _{tot}	-	10	18	nC	
Gate-Source Charge	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = -4.5 \text{ Vdc}, I_{D} = -2.4 \text{ Adc})$	Q _{gs}	-	1.5	-	1	
Gate-Drain Charge	.b = 2.17(do)	Q _{gd}	-	5.0	-	1	
BODY-DRAIN DIODE RATING	GS (Note 8)						
Diode Forward On-Voltage	$(I_S = -2.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = -2.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V _{SD}	_ _	-0.88 -0.75	-1.0 -	Vdc	
Reverse Recovery Time		t _{rr}	-	37	-	ns	
	$(I_S = -2.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s})$	t _a	-	16	-	1	
	a.5, at = 100 / v po)	t _b	_	21	-	1	
Reverse Recovery Stored Charge		Q _{RR}	_	0.025	_	μС	

$\textbf{SCHOTTKY RECTIFIER ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted) \ (Note \ 8)$

Maximum Instantaneous Forward Voltage		V _F	T _J = 25°C	T _J = 125°C	V
	$I_F = 1.0 \text{ Adc}$ $I_F = 2.0 \text{ Adc}$		0.47 0.58	0.39 0.53	
Maximum Instantaneous Reverse Current	.,	I _R	T _J = 25°C	T _J = 125°C	mA
	$V_R = 20 \text{ Vdc}$		0.05	10	
Maximum Voltage Rate of Change	V _R = 20 Vdc	dV/dt	10,000		V/μs

Handling precautions to protect against electrostatic discharge is mandatory.
 Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.
 Switching characteristics are independent of operating junction temperature.

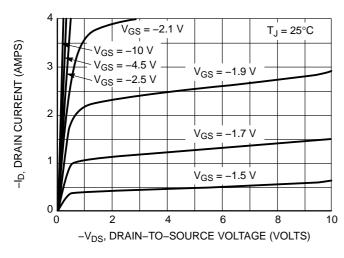


Figure 1. On-Region Characteristics.

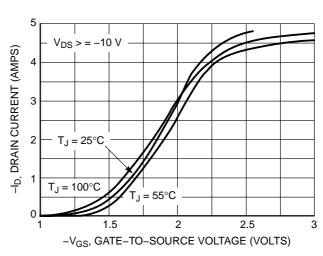


Figure 2. Transfer Characteristics.

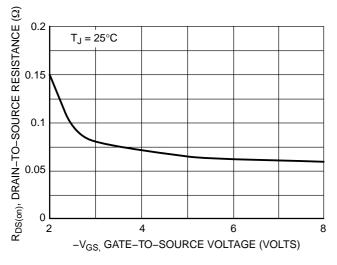


Figure 3. On–Resistance vs. Gate–to–Source Voltage.

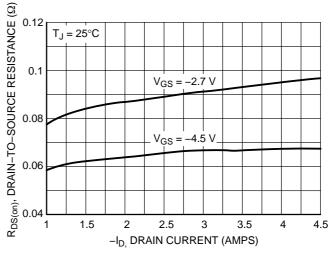


Figure 4. On–Resistance vs. Drain Current and Gate Voltage.

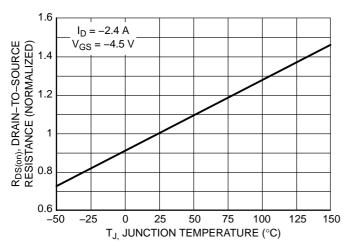


Figure 5. On–Resistance Variation with Temperature.

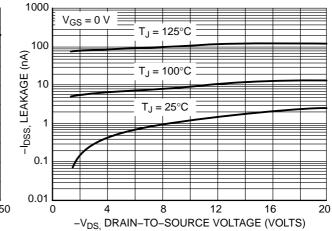
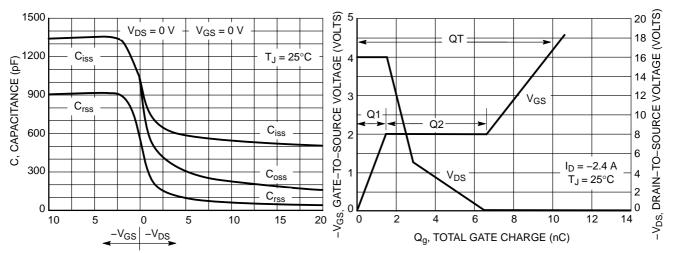


Figure 6. Drain-to-Source Leakage Current vs. Voltage.



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge



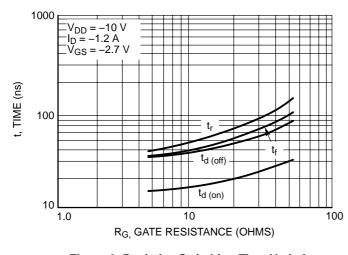


Figure 9. Resistive Switching Time Variation versus Gate Resistance

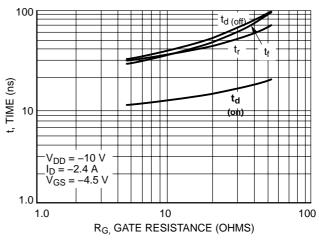


Figure 10. Resistive Switching Time Variation versus Gate Resistance

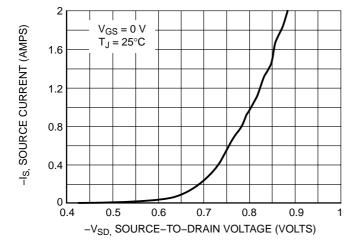


Figure 11. Diode Forward Voltage versus Current

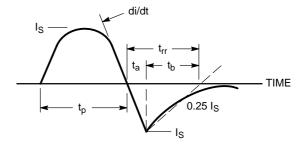


Figure 12. Diode Reverse Recovery Waveform

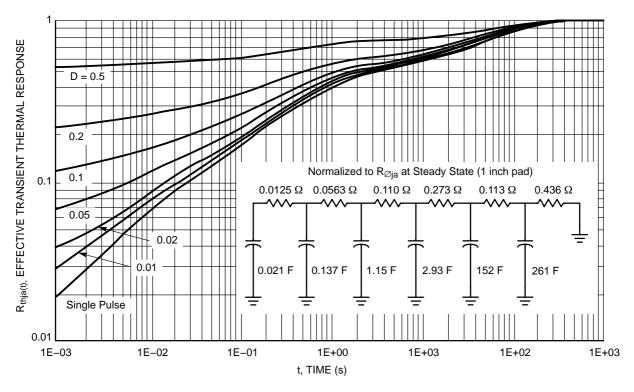


Figure 13. FET Thermal Response

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

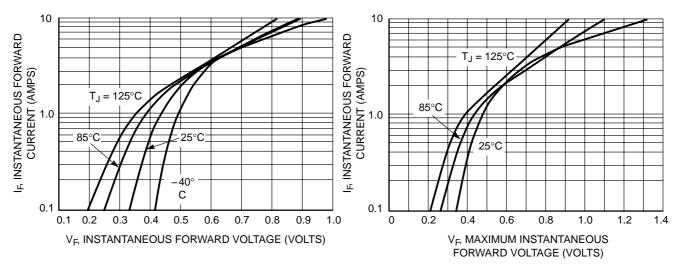


Figure 14. Typical Forward Voltage

Figure 15. Maximum Forward Voltage

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

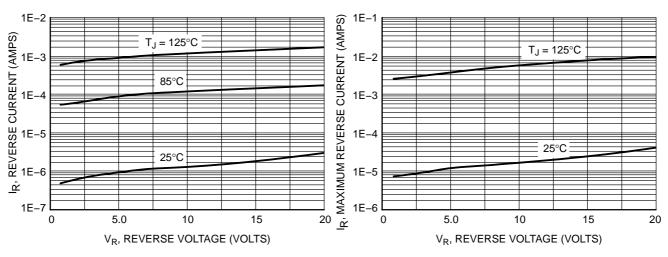


Figure 16. Typical Reverse Current

Figure 17. Maximum Reverse Current

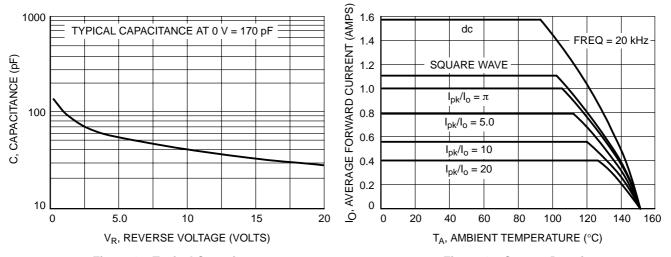


Figure 18. Typical Capacitance

Figure 19. Current Derating

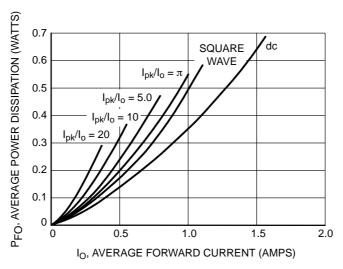


Figure 20. Forward Power Dissipation

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

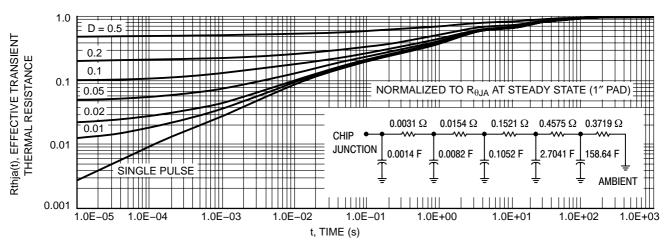
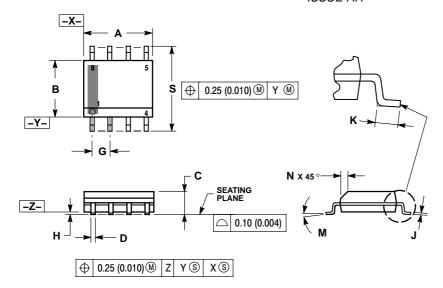


Figure 21. Schottky Thermal Response

PACKAGE DIMENSIONS

SOIC-8 NB CASE 751-07 **ISSUE AH**



NOTES

- DIMENSIONING AND TOLERANCING PER
- DIMENSIONING AND TOLERANCING PER ANSI Y14-5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07

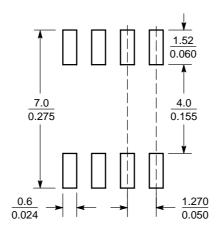
	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.053 0.069		
D	0.33	0.51	0.013	0.020	
G	1.27	7 BSC	0.050 BSC		
Н	0.10	0.25	0.004 0.010		
J	0.19	0.25	0.007 0.010		
K	0.40	1.27	0.016 0.050		
M	0 °	8 °	0 ° 8		
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

STYLE 18:

ANODE PIN 1.

- ANODE
- 3. SOURCE GATE
- 4. DRAIN 5.
- DRAIN
- CATHODE
- 8. CATHODE

SOLDERING FOOTPRINT*



mm_\ SCALE 6:1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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